

PROCEEDINGS OF SPIE

Polarization: Measurement, Analysis, and Remote Sensing XIV

**David B. Chenault
Dennis H. Goldstein**
Editors

**27 April – 8 May 2020
Online Only, United States**

Sponsored and Published by
SPIE

Volume 11412

Proceedings of SPIE 0277-786X, V. 11412

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Polarization: Measurement, Analysis, and Remote Sensing XIV, edited by David B. Chenault, Dennis H. Goldstein,
Proc. of SPIE Vol. 11412, 1141201 · © 2020 SPIE · CCC code: 0277-786X/20/\$21 · doi: 10.1117/12.2572612

Proc. of SPIE Vol. 11412 1141201-1

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Author(s), "Title of Paper," in *Polarization: Measurement, Analysis, and Remote Sensing XIV*, edited by David B. Chenault, Dennis H. Goldstein, Proceedings of SPIE Vol. 11412 (SPIE, Bellingham, WA, 2020) Seven-digit Article CID Number.

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510636019
ISBN: 9781510636026 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445

SPIE.org

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